

# “HALF-BRIDGE” IGBT MODULE

## Feature

- Smart field stopper + Trench design technology
- Low VCE (sat)
- Low Turn-off losses
- Short tail current for over 20KHz

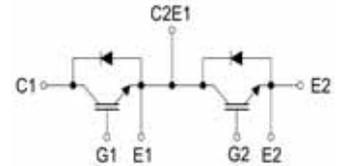
## Applications

- Motor controls
- VVVF inverters
- Inverter-type welding MC over 18KHZ
- SMPS, Electrolysis
- UPS/EPS, Robotics



Package : V1

**V<sub>CES</sub> = 600V**  
**I<sub>c</sub> = 150A**  
**V<sub>CE(ON)</sub> typ. = 1.5V**  
**@I<sub>c</sub> = 150A**



## Absolute Maximum Ratings @ T<sub>j</sub> = 25°C (Per Leg)

| Symbol           | Parameter                                                         | Condition                     | Ratings   | Unit |
|------------------|-------------------------------------------------------------------|-------------------------------|-----------|------|
| V <sub>CES</sub> | Collector-to-Emitter Voltage                                      | T <sub>c</sub> = 25°C         | 600       | V    |
| V <sub>GES</sub> | Gate emitter voltage                                              |                               | ± 20      | V    |
| I <sub>c</sub>   | Continuous Collector Current                                      | T <sub>c</sub> = 80°C (25°C)  | 150 (210) | A    |
| I <sub>CP</sub>  | Pulsed collector current                                          | T <sub>c</sub> = 25°C         | 300       | A    |
| I <sub>F</sub>   | Diode Continuous Forward Current                                  | T <sub>c</sub> = 80°C (25°C)  | 150 (210) | A    |
| I <sub>FM</sub>  | Diode Maximum Forward Current                                     | T <sub>c</sub> = 25°C         | 300       | A    |
| t <sub>p</sub>   | Short circuit test, V <sub>GE</sub> = 15V, V <sub>CC</sub> = 360V | T <sub>c</sub> = 150°C (25°C) | 6 (8)     | μs   |
| V <sub>iso</sub> | Isolation Voltage test                                            | AC @ 1 minute                 | 2500      | V    |
| T <sub>j</sub>   | Junction Temperature                                              |                               | -40 ~ 150 | °C   |
| T <sub>stg</sub> | Storage Temperature                                               |                               | -40 ~ 125 | °C   |
| Weight           | Weight of Module                                                  |                               | 190       | g    |
| M <sub>d</sub>   | Mounting torque with screw : M5                                   |                               | 2.0       | N.m  |
| T <sub>d</sub>   | Terminal connection torque : M5                                   |                               | 2.0       | N.m  |

## Static Characteristics @ T<sub>j</sub> = 25°C (unless otherwise specified)

| Parameters          |                                         | Min | Typ  | Max  | Unit | Test conditions                                          |
|---------------------|-----------------------------------------|-----|------|------|------|----------------------------------------------------------|
| V <sub>CE(ON)</sub> | Collector-to-Emitter Saturation Voltage |     | 1.50 | 1.95 | V    | I <sub>c</sub> = 150A, V <sub>GE</sub> = 15V             |
| V <sub>GE(th)</sub> | Gate Threshold Voltage                  |     | 5.8  | 6.5  |      | V <sub>CE</sub> = V <sub>GE</sub> , I <sub>c</sub> = 4mA |
| I <sub>CES</sub>    | Zero Gate Voltage Collector Current     | —   | —    | 5.0  | mA   | V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V             |
| I <sub>GES</sub>    | Gate-to-Emitter Leakage Current         | —   | —    | 400  | nA   | V <sub>CE</sub> = 0V, V <sub>GE</sub> = 20V              |
| V <sub>F</sub>      | Forward voltage drop                    |     | 1.6  | 1.9  | V    | I <sub>F</sub> = 150A                                    |
| R <sub>GINT</sub>   | Integrated gate resistor                | —   | 2    | —    | Ω    |                                                          |

**Electrical Characteristic Values (IGBT / DIODE) @ T<sub>j</sub> = 25°C (unless otherwise specified)**

| Parameters          |                                 | Min | Typ  | Max | Unit | Test conditions                                                                                                                |
|---------------------|---------------------------------|-----|------|-----|------|--------------------------------------------------------------------------------------------------------------------------------|
| C <sub>iss</sub>    | Input capacitance               | —   | 9200 | —   | pF   | V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V<br>f = 1 MHz                                                                       |
| C <sub>oss</sub>    | Output capacitance              | —   | 580  | —   |      |                                                                                                                                |
| C <sub>rss</sub>    | Reverse transfer capacitance    | —   | 270  | —   |      |                                                                                                                                |
| t <sub>d(on)</sub>  | Turn-on delay time              | —   | 125  | —   | ns   | Inductive Switching (125 )<br>V <sub>CC</sub> = 300V<br>I <sub>C</sub> = 150A, V <sub>GE</sub> = ±15V<br>R <sub>G</sub> = 3.3Ω |
| t <sub>r</sub>      | Rise time                       | —   | 30   | —   |      |                                                                                                                                |
| t <sub>d(off)</sub> | Turn-off delay time             | —   | 340  | —   |      |                                                                                                                                |
| t <sub>f</sub>      | Fall time                       | —   | 60   | —   |      |                                                                                                                                |
| V <sub>BR</sub>     | Cathode-Anode breakdown Voltage | 600 | 650  | —   | V    |                                                                                                                                |
| I <sub>RM</sub>     | Maximum Reverse Leakage Current | —   | —    | 250 | μA   | V <sub>R</sub> = 600V                                                                                                          |
| t <sub>rr</sub>     | Reverse Recovery Time           | —   | 130  | —   | ns   | I <sub>F</sub> = 150A, V <sub>R</sub> = 300V                                                                                   |
| Q <sub>rr</sub>     | Reverse Recovery Charge         | —   | 6.9  | —   | uC   | di / dt = 2100A / μs                                                                                                           |

**Thermal Characteristics**

| Symbol           | Parameter                                     | Min | Typ  | Max  | Unit |
|------------------|-----------------------------------------------|-----|------|------|------|
| R <sub>θJC</sub> | Junction-to-Case (IGBT Part, Per 1/2 Module)  | -   | -    | 0.44 | /W   |
| R <sub>θJC</sub> | Junction-to-Case (Diode Part, Per 1/2 Module) | -   | -    | 0.77 |      |
| R <sub>θCS</sub> | Case-to-Heat Sink (Conductive grease applied) | -   | 0.05 | -    |      |

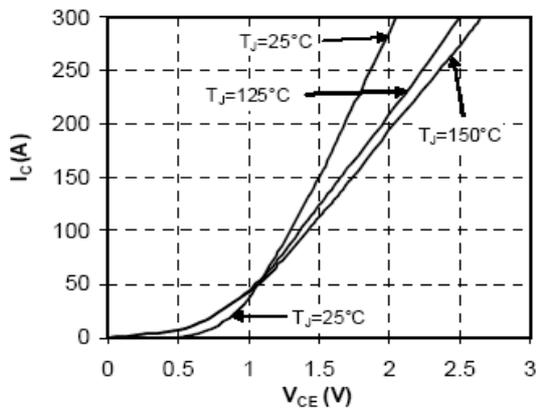


Fig 1. Typ. IGBT Output Characteristics

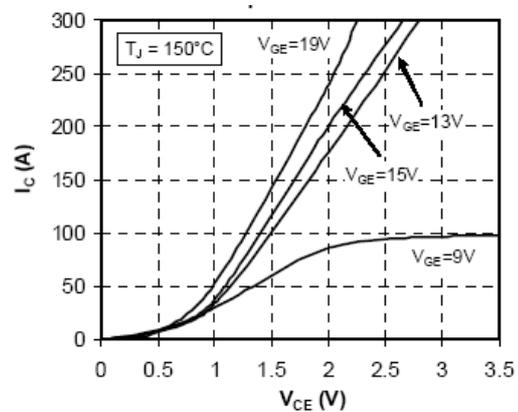
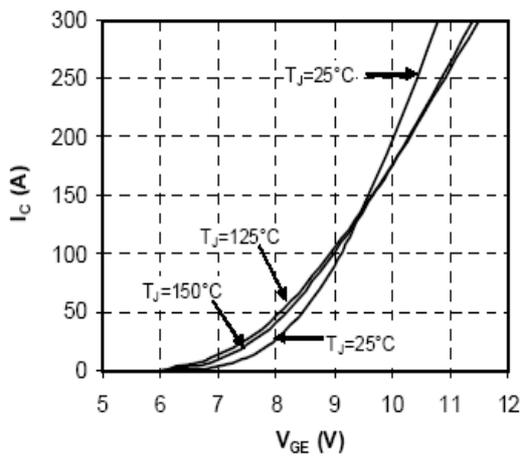
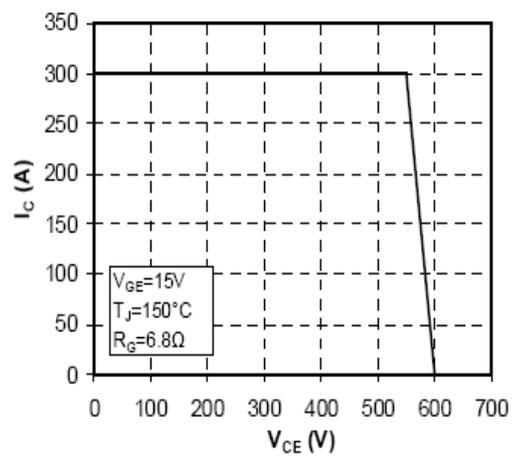


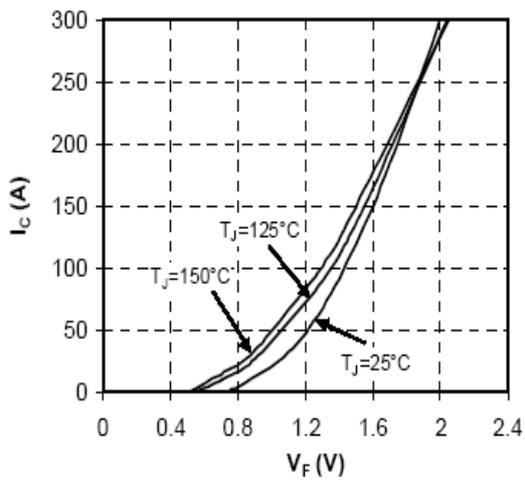
Fig 2. Typ. IGBT Out Characteristics



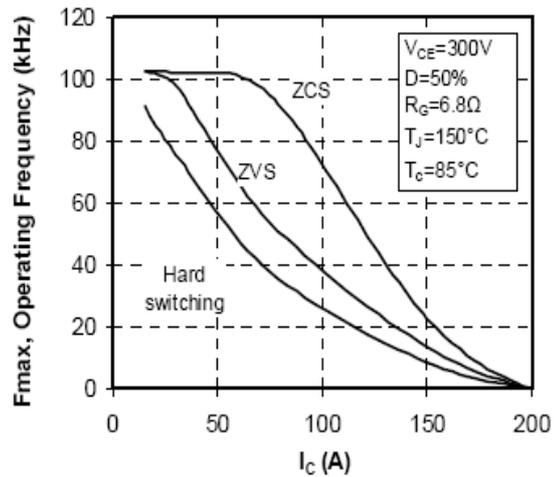
**Fig 3. Typ. Transfer Characteristics**



**Fig 4. Reverse Bias Operating Area**

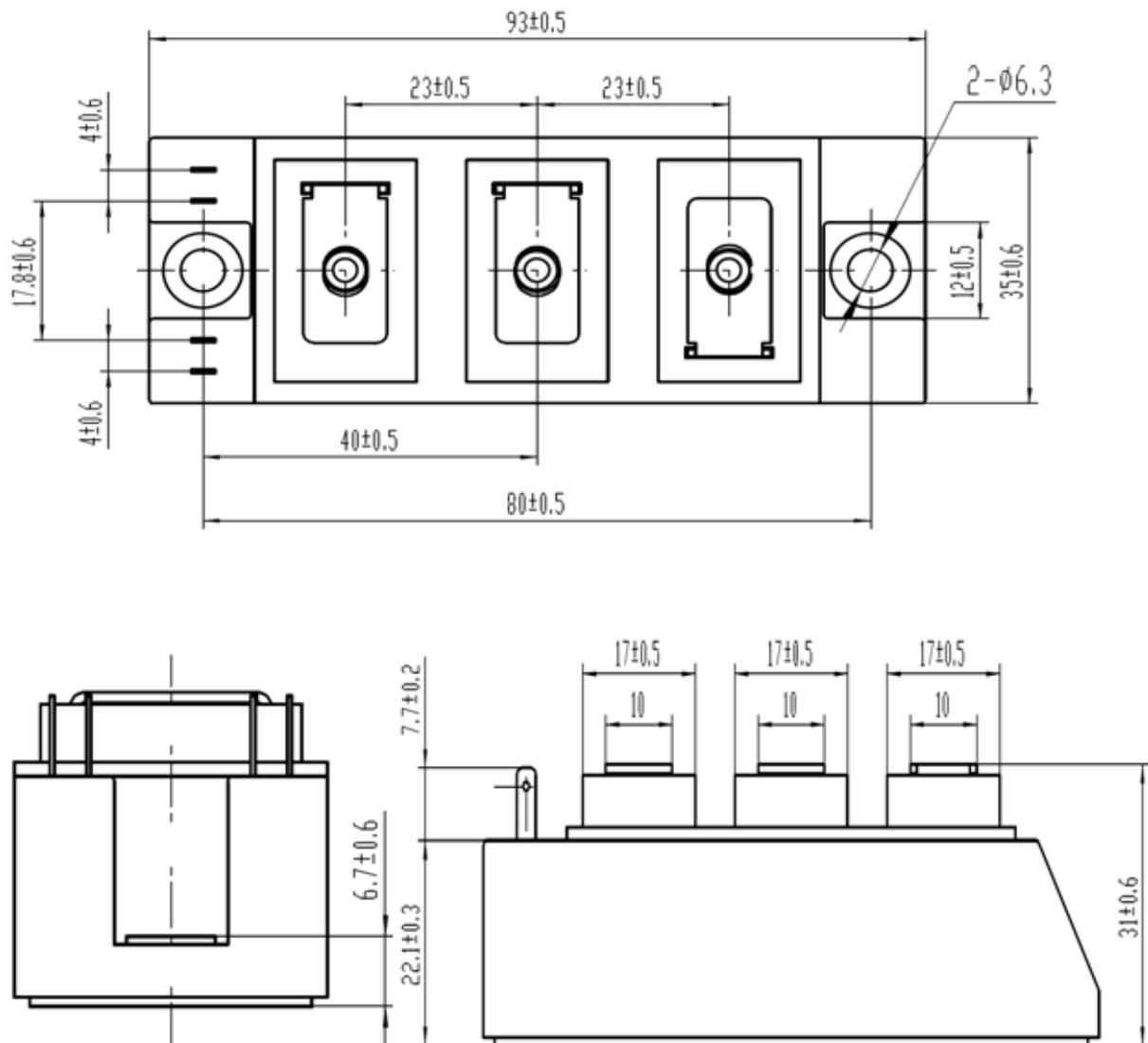


**Fig 5. Forward Characteristics of Diode**



**Fig 6. Operating Frequency vs Collector Current**

**Package Outline** (dimensions in mm)



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